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Supporting information for article:

Lorentz factor for time-of-flight neutron Bragg and total scattering

Yuanpeng Zhang, Jue Liu and Matthew G. Tucker



Figure S1 The refinement against the S(Q) pattern for an Si standard sample measured on both the NOMAD and POWGEN diffractometers at the SNS, ORNL. In this case, no *Q*-dependent scale factor is applied.

Figure S2 The refinement against the S(Q) pattern for an Si standard sample measured on both the NOMAD and POWGEN diffractometers at the SNS, ORNL. In this case, a multiplicative factor $1/Q^4$ is applied.

Figure S3 The refinement against the TOF Bragg pattern for an Si standard sample measured on both the NOMAD and POWGEN diffractometers at the SNS, ORNL. In this case, a multiplicative factor d^4 is applied.

Figure S4 The refinement against the TOF Bragg pattern for an Si standard sample measured on both the NOMAD and POWGEN diffractometers at the SNS, ORNL. In this case, a multiplicative factor d^2 is applied.

Figure S5 The refinement against the TOF Bragg pattern for an Si standard sample measured on both the NOMAD and POWGEN diffractometers at the SNS, ORNL. In this case, no *d*-dependent scale factor is applied.

Figure S6 (a) The description of the symmetry component of the peak shape of NOMAD SQ data. The detailed description of the back-to-back exponential and the Gaussian/Lorentzian components can be found in the TOPAS macro. (b) Comparison of the pseudo-Voigt fitted resolution function (from individual Si reflections) and the simulated Gaussian/Lorentzian components.